

LinearL2™ Power MOSFET w/Extended FBSOA

IXTK110N20L2 IXTX110N20L2

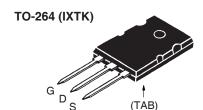
N-Channel Enhancement Mode Guaranteed FBSOA Avalanche Rated

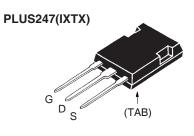


Symbol	Test Conditions	Maximum Ratings		
V _{DSS}	$T_J = 25^{\circ}C \text{ to } 150^{\circ}C$	200	V	
V_{DGR}	$T_J^{}=25^{\circ}\text{C}$ to 150°C, $R_{gs}^{}=1\text{M}\Omega$	200	V	
V _{GSS}	Continuous	±20	V	
V _{GSM}	Transient	±30	V	
I _{D25}	T _C = 25°C	110	A	
I _{DM}	$T_{\rm C} = 25^{\circ}$ C, Pulse Width Limited by $T_{\rm JM}$	275	Α	
I _A	T _C = 25°C	55	A	
E _{AS}	$T_{c} = 25^{\circ}C$	5	J	
P _D	$T_{c} = 25^{\circ}C$	960	W	
T _J		-55+150	°C	
T _{JM}		150	°C	
T _{stg}		-55+150	°C	
T _L	1.6mm (0.063 in.) from Case for 10s	300	°C	
T _{SOLD}	Plastic Body for 10s	260	°C	
M _d	Mounting Torque (IXTK)	1.13/10	Nm/lb.in.	
F _c	Mounting Force (IXTX)	20120 / 4.527	N/lb.	
Weight	TO-264 PLUS247	10 6	g g	

SymbolTest ConditionsChara $(T_J = 25^{\circ}C, Unless Otherwise Specified)$ Min.			acteristic Values Typ. Max.		
BV _{DSS}	$V_{GS} = 0V, I_D = 1mA$	200			V
V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 3mA$	2.0		4.5	V
I _{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			±200	nA
I _{DSS}	$V_{DS} = V_{DSS}, V_{GS} = 0V$			50	μΑ
	$T_J = 125$ °C			2.5	mΑ
R _{DS(on)}	$V_{GS} = 10V, I_{D} = 0.5 \bullet I_{D25}, Note 1$			24	mΩ

 $V_{DSS} = 200V$ $I_{D25} = 110A$ $R_{DS(an)} \le 24m\Omega$





G = Gate	D	=	Drain
S = Source	TAB	=	Drain

Features

- Designed for Linear Operation
- International Standard Packages
- Avalanche Rated
- Guaranteed FBSOA at 75°C

Advantages

- Easy to Mount
- Space Savings
- High Power Density

Applications

- Solid State Circuit Breakers
- Soft Start Controls
- Linear Amplifiers
- Programmable Loads
- Current Regulators



Symbol (T _J = 25		Test Conditions Unless Otherwise Specified)	Char Min.	acteristi Typ.	c Values Max.
g _{fs}		V _{DS} = 10V, I _D = 0.5 • I _{D25} , Note 1	55	75	95 S
C _{iss})			23	nF
C _{oss}	}	$V_{GS} = 0V, V_{DS} = 25V, f = 1MHz$		2160	pF
\mathbf{C}_{rss}	J			320	pF
t _{d(on)})	Parietics Ossitables Times		40	ns
t,		Resistive Switching Times $V_{GS} = 10V, V_{DS} = 0.5 \cdot V_{DSS}, I_{D} = 0.5 \cdot I_{D25}$		100	ns
t _{d(off)}				33	ns
t _f	$I \cap C = I $ (External)	$H_{G} = 102 \text{ (External)}$		135	ns
$Q_{g(on)}$)			500	nC
Q _{gs}	}	$V_{GS} = 10V, V_{DS} = 0.5 \cdot V_{DSS}, I_{D} = 0.5 \cdot I_{D25}$		110	nC
\mathbf{Q}_{gd}	J			182	nC
R _{thJC}					0.13 °C/W
R _{thCS}				0.15	°C/W

Safe-Operating-Area Specification

Symbol	Test Conditions		Characteristic Values			
		Min.	Тур.	Max.		
SOA	$V_{DS} = 200V, I_{D} = 2.88A, T_{C} = 75^{\circ}C, Tp = 5s$	575		W		

Source-Drain Diode

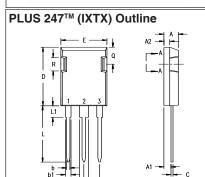
Symbol Test Conditions Characteristic		Values			
$(T_{J} = 25^{\circ}C,$	Unless Otherwise Specified)	Vin.	Тур.	Max	
I _s	$V_{GS} = 0V$			110	Α
I _{sm}	Repetitive, Pulse Width Limited by T_{JM}			440	Α
V _{SD}	$I_F = 55A$, $V_{GS} = 0V$, Note 1			1.35	V
$\left\{egin{array}{c} \mathbf{t}_{rr} & \\ \mathbf{I}_{RM} & \\ \mathbf{Q}_{RM} & \end{array}\right\}$	$I_F = 55A$, -di/dt = 100A/ μ s, $V_R = 100V$, $V_{GS} = 0V$		420 39 8.3		ns A µC

Note 1. Pulse test, $t \le 300 \mu s$; duty cycle, $d \le 2\%$.

ADVANCE TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

TO-264 (IXTK) Outline — A — | Ø Р Ф Ø К ® D В ® - GATE 4 - DRAIN (COLLECTOR) - SOURCE (EMITTER) SYM



Terminals:

- 2 Drain (Collector)
- 3 Source (Emitter)
- 4 Drain (Collector)

Dim.	Millimeter		Inches		
	Min.	Max.	Min.	Max.	
Α	4.83	5.21	.190	.205	
A_1	2.29	2.54	.090	.100	
A ₂	1.91	2.16	.075	.085	
b	1.14	1.40	.045	.055	
b_1	1.91	2.13	.075	.084	
b_2	2.92	3.12	.115	.123	
С	0.61	0.80	.024	.031	
D	20.80	21.34	.819	.840	
Е	15.75	16.13	.620	.635	
е	5.45	BSC	.215 BSC		
L	19.81	20.32	.780	.800	
L1	3.81	4.32	.150	.170	
Q	5.59	6.20	.220	0.244	
R	4.32	4.83	.170	.190	

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Fig. 1. Output Characteristics

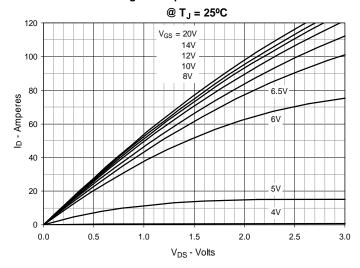


Fig. 2. Extended Output Characteristics

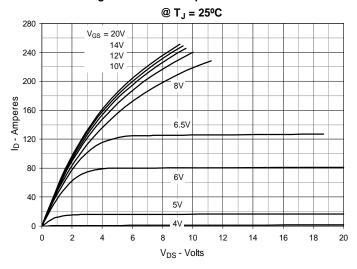


Fig. 3. Output Characteristics

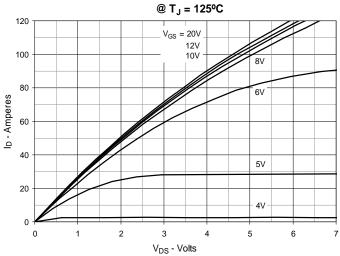


Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 55A$ Value vs. Junction Temperature

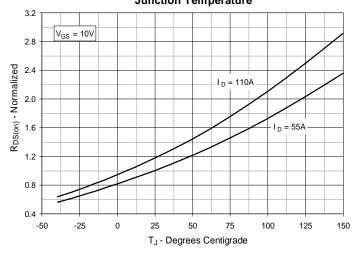


Fig. 5. $R_{DS(on)}$ Normalized to I_D = 55A Value vs.

Drain Current

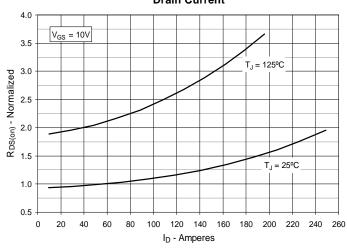
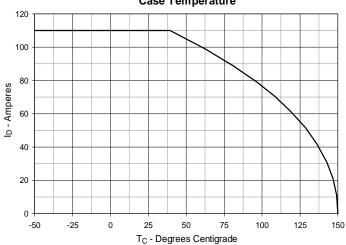
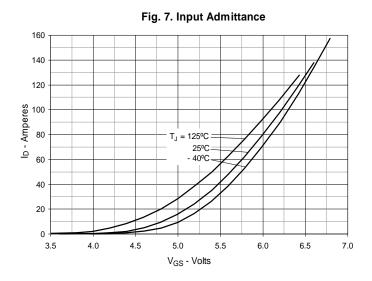


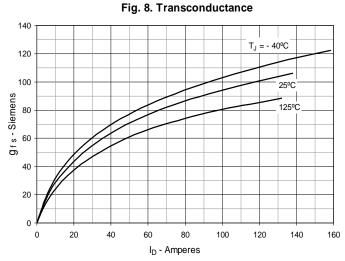
Fig. 6. Maximum Drain Current vs.

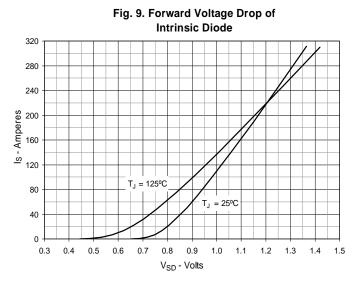
Case Temperature

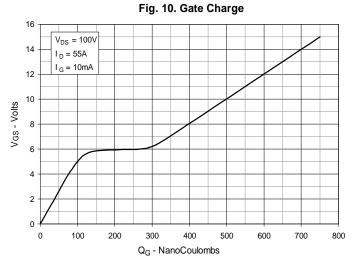


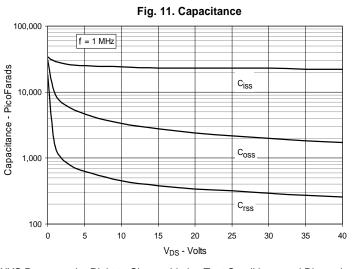


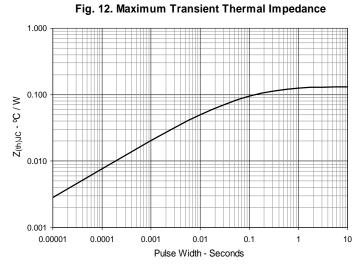












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Fig. 13. Forward-Bias Safe Operating Area

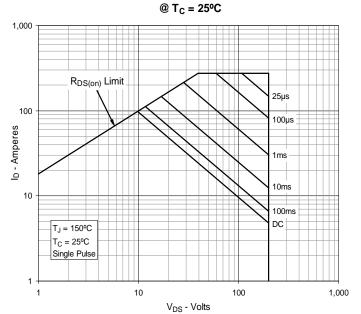


Fig. 14. Forward-Bias Safe Operating Area $@T_C = 75^{\circ}C$

